

Notice of References Cited

Application/Control No.

10/603,055

Applicant(s)/Patent Under
Reexamination
BLASI ET AL.

Examiner

Mary C. Jacob

Art Unit

2123

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,671,843	12-2003	Kebichi et al.	714/733
*	B	US-6,658,633	12-2003	Deyins et al.	716/5
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Zarrineh et al, "Automatic Generation and Validation of Memory Test Models for High Performance Microprocessors", Proceedings of the 2001 International Conference on Computer Design, pages 526-529, 23-26 Sept, 2001
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.